Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/696,636	AKASHE ET AL.	
Examiner	Art Unit	
Anthony Weier	1761	

SEARCHED				
Class	Subclass	Date	Examiner	
updated	previous search	11/1/2006	AW	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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